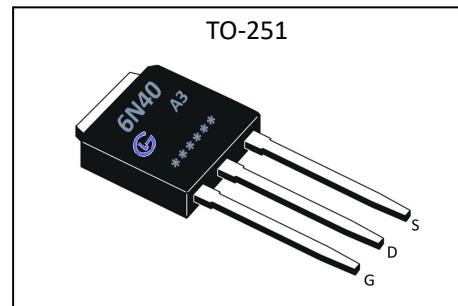


General Description

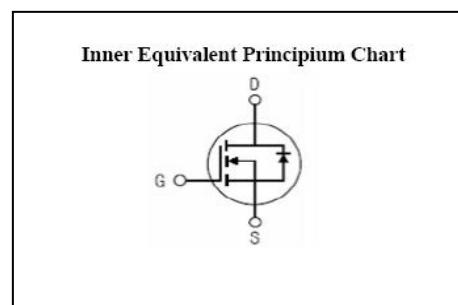
GL6N40A3 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-251, which accords with the RoHS standard.

| | | |
|----------------------------------------|------|---|
| V _{DSS} | 400 | V |
| I _D | 6 | A |
| P _D (T _C =25 °C) | 75 | W |
| R _{DS(ON)type} | 0.75 | Ω |



Features

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test



Applications

- Power switch circuit of adaptor and charger

Absolute (T_C= 25°C unless otherwise specified)

| Symbol | Parameter | Rating | Units |
|-----------------------------------|--------------------------------------------------|-----------------|-------|
| V _{DSS} | Drain-to-Source Voltage | 400 | V |
| I _D | Continuous Drain Current | 6.0 | A |
| | Continuous Drain Current T _C = 100 °C | 4.2 | A |
| I _{DM} ^{a1} | Pulsed Drain Current | 36.0 | A |
| V _{GS} | Gate-to-Source Voltage | ±30 | V |
| E _{AS} ^{a2} | Single Pulse Avalanche Energy | 200 | mJ |
| E _{AR} ^{a1} | Avalanche Energy, Repetitive | 26 | mJ |
| I _{AR} ^{a1} | Avalanche Current | 2.3 | A |
| dv/dt ^{a3} | Peak Diode Recovery dv/dt | 5.0 | V/ns |
| P _D | Power Dissipation | 75 | W |
| | Derating Factor above 25°C | 0.6 | W/°C |
| T _J , T _{stg} | Operating Junction and Storage Temperature Range | 150, -55 to 150 | °C |
| T _L | Maximum Temperature for Soldering | 300 | °C |



GL6N40A3

GL Silicon N-Channel Power MOSFET

Electrical Characteristics (T_c= 25°C unless otherwise specified)

| OFF Characteristics | | | | | | |
|-------------------------------------|-----------------------------------|-------------------------------------------------------------------|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| V _{DSS} | Drain to Source Breakdown Voltage | V _{GS} =0V, I _D =250μA | 400 | -- | -- | V |
| ΔBV _{DSS} /ΔT _J | Bvdss Temperature Coefficient | I _D =250uA, Reference 25°C | -- | 0.55 | -- | V/°C |
| I _{DSS} | Drain to Source Leakage Current | V _{DS} =400V, V _{GS} = 0V, T _a =25°C | -- | -- | 1 | μA |
| | | V _{DS} =320V, V _{GS} =0V, T _a =125°C | -- | -- | 250 | |
| I _{GSS(F)} | Gate to Source Forward Leakage | V _{GS} =+30V | -- | -- | 10 | μA |
| I _{GSS(R)} | Gate to Source Reverse Leakage | V _{GS} =-30V | -- | -- | -10 | μA |

| ON Characteristics | | | | | | |
|----------------------------|-------------------------------|----------------------------------------------------------|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| R _{DS(ON)} | Drain-to-Source On-Resistance | V _{GS} =10V, I _D =3.0A | -- | 0.75 | 1.0 | Ω |
| V _{GS(TH)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 2.0 | 3.0 | 4.0 | V |
| Pulse width tp≤380μs, δ≤2% | | | | | | |

| Dynamic Characteristics | | | | | | |
|-------------------------|------------------------------|-------------------------------------------|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| g _{fs} | Forward Transconductance | V _{DS} =15V, I _D =3A | -- | 4.5 | -- | S |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =25V | -- | 540 | -- | pF |
| C _{oss} | Output Capacitance | f=1.0MHz | -- | 68 | -- | |
| C _{rss} | Reverse Transfer Capacitance | | -- | 7.5 | -- | |

| Resistive Switching Characteristics | | | | | | |
|-------------------------------------|----------------------------------|---------------------------------------------|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| t _{d(ON)} | Turn-on Delay Time | I _D =6.0A, V _{DD} =200V | -- | 9 | -- | ns |
| t _r | Rise Time | | -- | 11 | -- | |
| t _{d(OFF)} | Turn-Off Delay Time | | -- | 29 | -- | |
| t _f | Fall Time | | -- | 16 | -- | |
| Q _g | Total Gate Charge | I _D =6.0A, V _{DD} =200V | -- | 14 | -- | nC |
| Q _{gs} | Gate to Source Charge | | -- | 3 | -- | |
| Q _{gd} | Gate to Drain ("Miller")Charge | | -- | 6.5 | -- | |

Source-Drain Diode Characteristics

| Symbol | Parameter | Test Conditions | Rating | | | Units |
|-----------------|----------------------------------------|-----------------------------------------------------|--------|------|------|-------|
| | | | Min. | Typ. | Max. | |
| I _S | Continuous Source Current (Body Diode) | | -- | -- | 6 | A |
| I _{SM} | Maximum Pulsed Current (Body Diode) | | -- | -- | 24 | A |
| V _{SD} | Diode Forward Voltage | I _S =6.0A, V _{GS} =0V | -- | -- | 1.5 | V |
| t _{rr} | Reverse Recovery Time | I _S =6.0A, T _j = 25°C | -- | 388 | -- | ns |
| Q _{rr} | Reverse Recovery Charge | di _F /dt=100A/us, V _{GS} =0V | -- | 1720 | -- | nC |

Pulse width tp≤380μs, δ≤2%

Thermal Characteristics

| Symbol | Parameter | Typ. | Units |
|------------------|---------------------|------|-------|
| R _{θJC} | Junction-to-Case | 1.67 | °C/W |
| R _{θJA} | Junction-to-Ambient | 62.5 | °C/W |

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

^{a2}: L=10.0mH, I_D=6.4A, Start T_j=25°C

^{a3}: I_{SD}=6A, di/dt ≤ 100A/us, V_{DD}≤BV_{DS}, Start T_j=25°C

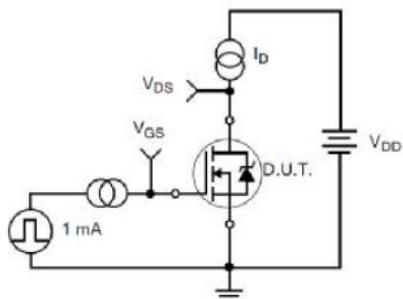
Test Circuits


Figure 17. Gate Charge Test Circuit

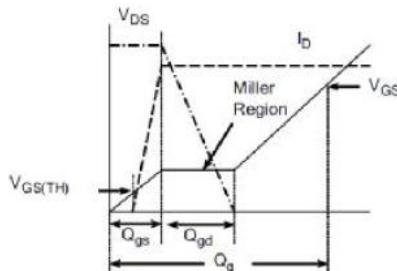


Figure 18. Gate Charge Waveform

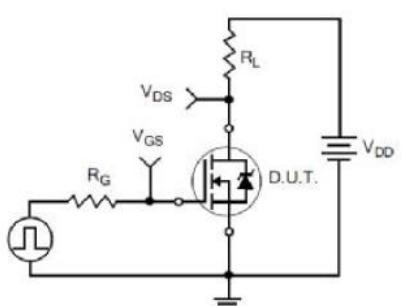


Figure 19. Resistive Switching Test Circuit

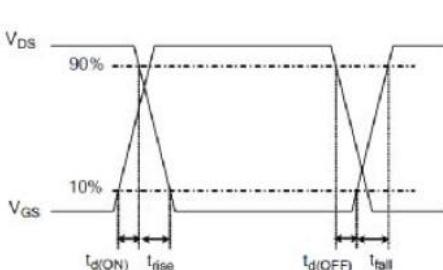
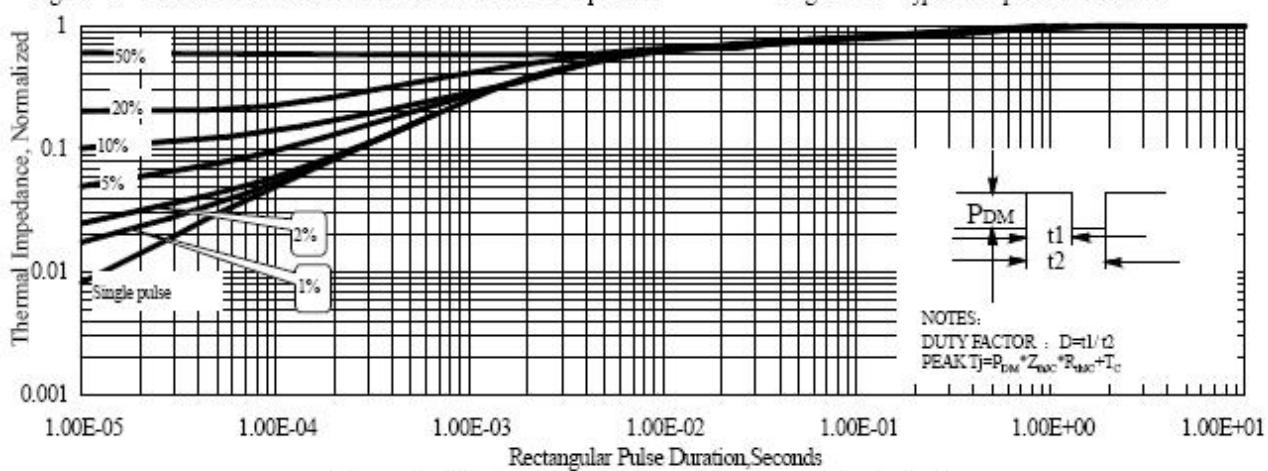
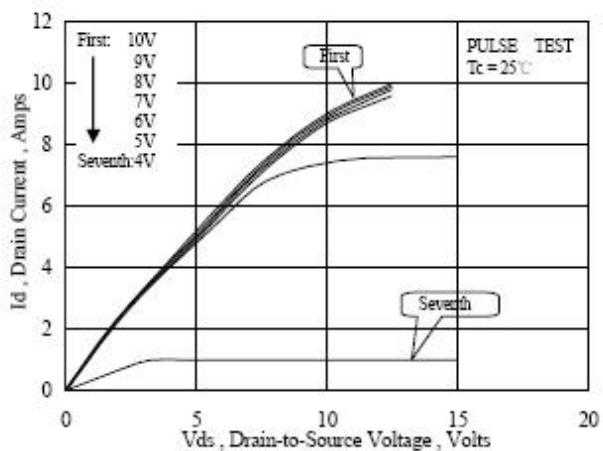
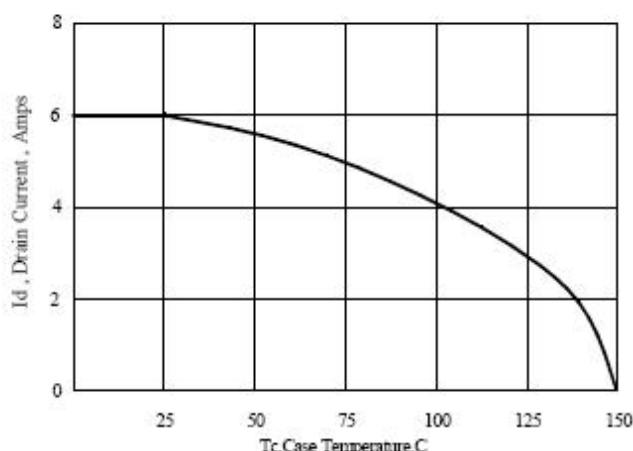
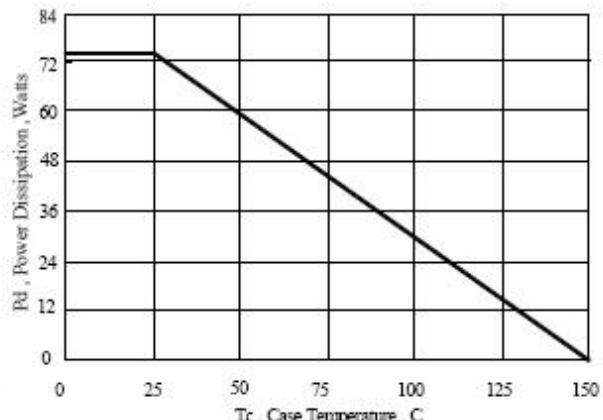
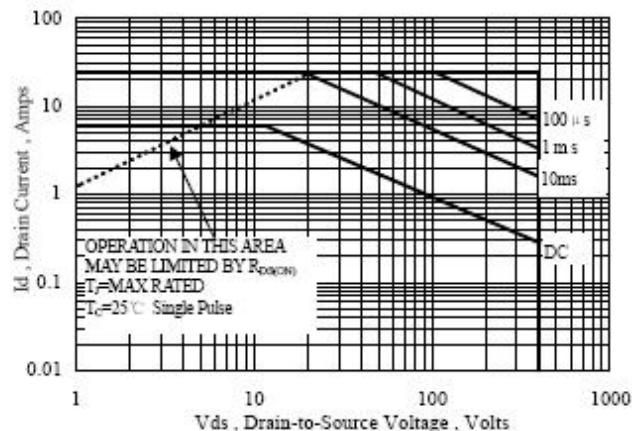


Figure 20. Resistive Switching Waveforms

Characteristics Curves



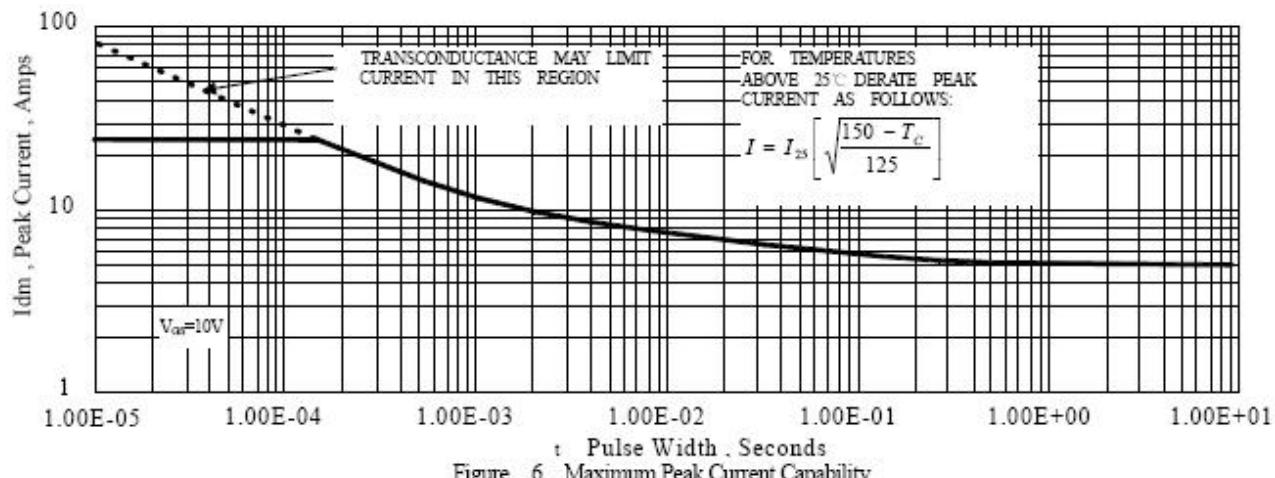
GL Silicon N-Channel Power MOSFET


Figure 6 Maximum Peak Current Capability

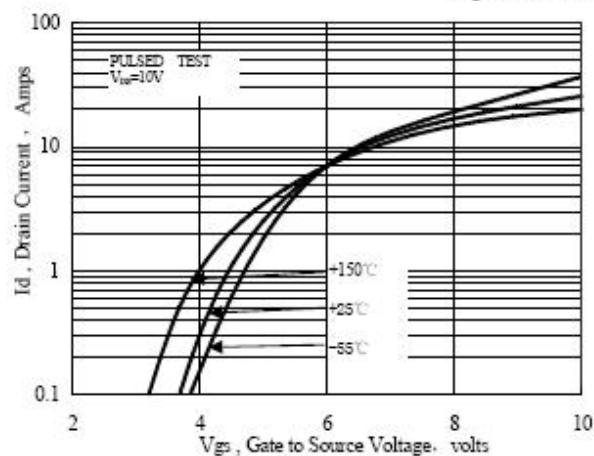


Figure 7 Typical Transfer Characteristics

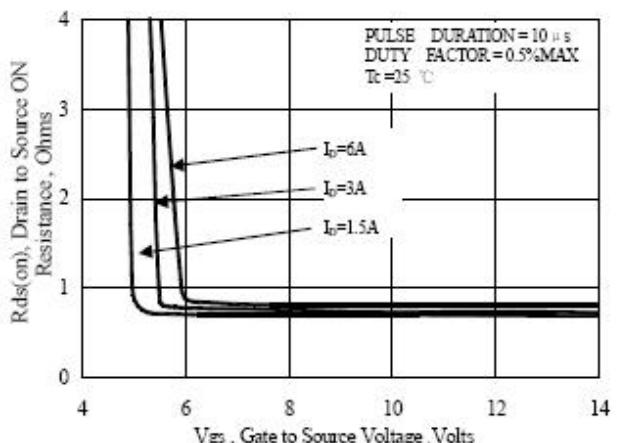


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

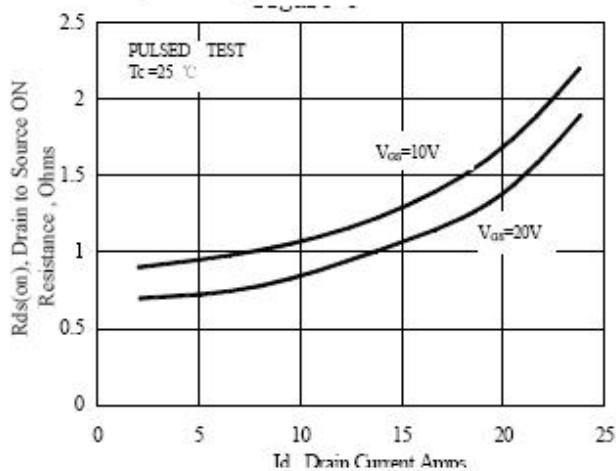


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

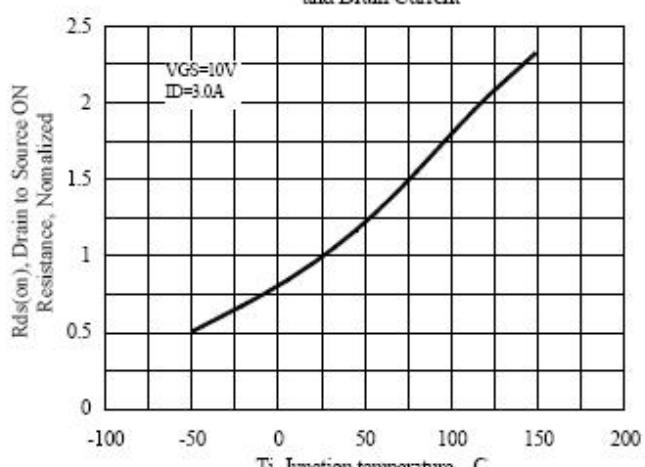


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

